## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination VANN, WARREN E. Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name ·	Classification
	A	US-2004/0075981	04-2004	Kim et al.	361/687
	В	US-2003/0137267	07-2003	Blake, John	318/471
	O	US-5,102,040	04-1992	Harvey, William J.	236/49.3
	ם	US-5,255,149	10-1993	Matsuo, Yoichi	361/103
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			·
	ł	US-			
	J	US-			
	K	US-		,	
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Ð					
	ο					
	R					
	S					·
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	w					
	х					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.